## **Amendments to the Claims:**

This listing of claims will replace all prior versions, and listings of claims in the application:

## **Listing of Claims:**

- 1. (Currently Amended) A data storage device, comprising:
- a write head for writing data onto a magnetic disk;
- a write circuit [[for generating]] <u>configured to generate</u> the write current to be supplied to said write head by using a supplied positive voltage and a supplied negative voltage;
- a converter [[for generating]] <u>configured to generate</u> said negative voltage to be supplied to said write circuit from said positive voltage; and
- a <u>programmable</u> controller [[for]] <u>configured to</u> variably [[setting]] <u>set</u> the magnitude of said negative voltage <u>based on information input to said controller</u>.
- 2. (Original) The data storage device according to claim 1, wherein said controller sets the magnitude of said negative voltage in accordance with an ambient temperature for said magnetic disk.
- 3. (Original) The data storage device according to claim 2, wherein said controller sets a large absolute value for said negative voltage if said ambient temperature is low, and sets a small absolute value for said negative voltage if said ambient temperature is high.
- 4. (Original) The data storage device according to claim 1, wherein said controller sets the magnitude of said negative voltage in accordance with the magnitude of said positive voltage.

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- 5. (Original) The data storage device according to claim 4, wherein said controller sets a large absolute value for said negative voltage if said positive voltage is low, and sets a small absolute value for said negative voltage if said positive voltage is high.
- 6. (Original) The data storage device according to claim 1, wherein said controller changes the magnitude of said negative voltage when said write head is not performing a write operation.
- 7. (Original) The data storage device according to claim 1, wherein said write circuit ensures that the write current value used for a specified period after the start of a write is greater than the write current value used after the elapse of the specified period.
- 8. (Original) The data storage device according to claim 1, wherein said write circuit is of a voltage-driven type that directly provides voltage drive for said write head.
- 9. (Original) The data storage device according to claim 1, wherein said converter comprises a register for storing a voltage command from said controller and a voltage converter for converting the voltage in accordance with the value stored in said register.
  - 10. (Currently Amended) A data write method, comprising:

[[a first step of]] receiving a seek command or a write command for a read/write head over a magnetic disk;

[[a second step of]] setting by a controller the magnitude of [[the]] a negative voltage to be supplied to a drive circuit for said read/write head in accordance with a specified condition based on information input to the controller, the negative voltage being generated from a positive voltage supplied to the drive circuit; and

[[a third step of]] causing said read/write head over said magnetic disk to perform a seek operation or a write operation.

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- 11. (Original) The data write method according to claim 10, wherein said specified condition is the ambient temperature for said magnetic disk.
- 12. (Original) The data write method according to claim 11, wherein said second step sets a large absolute value for said negative voltage if said ambient temperature is low and sets a small absolute value for said negative voltage if said ambient temperature is high.
- 13. (Currently Amended) The data write method according to claim 10, wherein said specified condition is the magnitude of said supplied [[said]] positive voltage.
- 14. (Original) The data write method according to claim 13, wherein said second step sets a large absolute value for said negative voltage if said positive voltage is low and sets a small absolute value for said negative voltage if said positive voltage is high.
- 15. (Currently Amended) A <u>computer-readable storage medium having a</u> program enabling a <u>computer to exercise a first function</u> <u>which comprises:</u>

<u>code</u> for receiving a seek command or a write command for a read/write head over a magnetic disk;

[[a second function]] <u>code</u> for setting, in accordance with a specified condition <u>based on information input to a controller</u>, the magnitude of the negative voltage <u>generated from a supplied positive voltage</u>, the negative voltage to be supplied to a write circuit which drives said read/write head; and

[[a third function]] <u>code</u> for causing said read/write head over said magnetic disk to perform a seek operation or a write operation.

16. (New) The data storage device of claim 1, wherein said controller uses stored voltage command information in a register to variably set the magnitude of said negative voltage.

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- 17. (New) The data storage device of claim 16, wherein the magnitude of said negative voltage is set to a predefined voltage defined by said stored voltage command information.
- 18. (New) The data storage device of claim 1, wherein said controller sets the magnitude of said negative voltage in accordance with the average value of said positive voltage.
- 19. (New) The method of claim 10, further comprising, prior to causing the read/write head to perform the seek operation or the write operation:

storing values of previous positive and negative voltages; measuring the value of a supplied positive voltage; and

computing the difference between the value of said supplied positive voltage and the value of said previous positive voltage;

wherein said specified condition used in setting the magnitude of the negative voltage is the computed difference.

20. (New) The method of claim 19, further comprising waiting for a preset period of time to allow the voltage to stabilize after setting the magnitude of the negative voltage before causing the read/write head to perform the seek operation or the write operation.